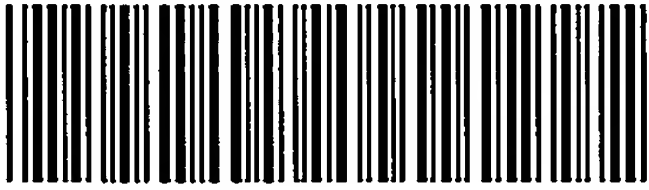


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/612,448	QIAN ET AL.	
	Examiner	Art Unit	
	Mark A. Chapman	1756	

SEARCHED			
Class	Subclass	Date	Examiner
430	114	5/5/2005	MC
	117		
	137.22		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
east	5/5/2005	MC
reviewed related cases		